Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/944,332	SHEN ET AL.
Examiner	Art Unit

2626

Qi Han

SEARCHED					
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Rich Dorvil	1/18/2007	QH		
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